# **Certificate of Test**

		Report No.: NW2108-F003-1	
1-71, Geumgok-ro, , 18511, Republic (	Hwaseong-si, Gyeonggi- of Korea		
	0 / Fax: +82-31-323-6071)	Page (1) / (59)	Your business' success starts with NCT
. Client			
	NA TECHNOLOGIES.Ir	IC	
○ Address : ′	19, Heolleung-ro 569-gil	, Gangnam-gu, Seoul, Ko	orea
○ Date of Re	ceipt : 2021-06-28		
. Use of Repo	ort : FCC & IC Approval		
3. Test Sample	9		
•	n / Model : A20 / SP100		
∘ FCC ID : S	37A-SP100 / IC : 8154A-	SP100	
. Place of Tes	st : ∎ Fixed test □ Fie	eld test	
(Address:21	I-71, Geumgok-ro, Hwas	seong-si, Gyeonggi-do, 1	8511, Republic of Korea)
5. Date of Tes	t : 2021-07-28 ~ 2021-0	8-05	
Test metho	d used : FCC Part 15 S	ubpart C 15 247	
. icstinctio		uppull o 10.247	
	RSS-247 Issue	e 2(2017-02), RSS-GEN	Issue 5(2019-03)
		e 2(2017-02), RSS-GEN	Issue 5(2019-03)
7. Testing Env	vironment :		Issue 5(2019-03)
○ Temperatur	<b>/ironment :</b> e: (25 ± 5) °C, Humidity: I	Less than 75 % R.H.	
○ Temperatur	<b>/ironment :</b> e: (25 ± 5) °C, Humidity: I	Less than 75 % R.H.	Issue 5(2019-03)
<ul> <li>Temperatur</li> <li>* Unless specif</li> </ul>	<b>/ironment :</b> e: (25 ± 5) °C, Humidity: I	Less than 75 % R.H. al methods, the tests were con	
<ul> <li>Temperatur</li> <li>* Unless specif</li> <li>8. Test Resu</li> </ul>	<b>vironment :</b> e: $(25 \pm 5)$ °C, Humidity: I ied otherwise in the individuant Its : Refer to the test res	Less than 75 % R.H. al methods, the tests were con sults	ducted on ambient conditions.
<ul> <li>Temperature</li> <li>* Unless specif</li> <li><b>3. Test Resu</b></li> <li>The results shown This Test Report</li> </ul>	<b>vironment :</b> e: $(25 \pm 5)$ °C, Humidity: I fied otherwise in the individuant <b>Its :</b> Refer to the test rest in this test report refer only to cannot be reproduced, exception	Less than 75 % R.H. al methods, the tests were con sults to the sample(s) tested unless t in full	ducted on ambient conditions.
<ul> <li>Temperature</li> <li>* Unless specif</li> <li>8. Test Resu</li> <li>The results shown This Test Report</li> </ul>	<b>vironment :</b> e: $(25 \pm 5)$ °C, Humidity: I fied otherwise in the individua <b>Its :</b> Refer to the test rest in this test report refer only f	Less than 75 % R.H. al methods, the tests were con sults to the sample(s) tested unless t in full	ducted on ambient conditions.
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<ul> <li>Temperature</li> <li>* Unless specif</li> <li>8. Test Resu</li> <li>The results shown This Test Report</li> </ul>	<b>vironment :</b> e: $(25 \pm 5)$ °C, Humidity: I ied otherwise in the individuant <b>Its :</b> Refer to the test rest in this test report refer only find cannot be reproduced, except not related to KOLAS recognition <b>Tested by</b>	Less than 75 % R.H. al methods, the tests were con sults to the sample(s) tested unless t in full ition and RRA designation.	nducted on ambient conditions. otherwise stated.
<ul> <li>Temperature</li> <li>* Unless specif</li> <li>8. Test Resu</li> <li>The results shown This Test Report This Test Report This test report is</li> </ul>	<b>vironment :</b> e: $(25 \pm 5)$ °C, Humidity: I fied otherwise in the individuant <b>Its :</b> Refer to the test rest in this test report refer only for cannot be reproduced, excep not related to KOLAS recogn	Less than 75 % R.H. al methods, the tests were con sults to the sample(s) tested unless t in full ition and RRA designation.	ducted on ambient conditions. otherwise stated.
<ul> <li>Temperature</li> <li>* Unless specif</li> <li>8. Test Resu</li> <li>The results shown This Test Report This Test Report This test report is</li> </ul>	<b>vironment :</b> e: $(25 \pm 5)$ °C, Humidity: I ied otherwise in the individuant <b>Its :</b> Refer to the test rest in this test report refer only find cannot be reproduced, except not related to KOLAS recognition <b>Tested by</b>	Less than 75 % R.H. al methods, the tests were con sults to the sample(s) tested unless t in full ition and RRA designation.	otherwise stated.
<ul> <li>Temperature</li> <li>* Unless specif</li> <li>8. Test Resu</li> <li>The results shown This Test Report This Test Report This test report is</li> </ul>	<b>vironment :</b> e: $(25 \pm 5)$ °C, Humidity: I ied otherwise in the individuant <b>Its :</b> Refer to the test rest in this test report refer only ficannot be reproduced, excep not related to KOLAS recogn	Less than 75 % R.H. al methods, the tests were con sults to the sample(s) tested unless t in full ition and RRA designation.	nducted on ambient conditions. otherwise stated.
<ul> <li>Temperature</li> <li>* Unless specif</li> <li>8. Test Resu</li> <li>The results shown This Test Report This Test Report This test report is</li> </ul>	<b>vironment :</b> e: $(25 \pm 5)$ °C, Humidity: I ied otherwise in the individuant <b>Its :</b> Refer to the test rest in this test report refer only ficannot be reproduced, excep not related to KOLAS recogn	Less than 75 % R.H. al methods, the tests were con sults to the sample(s) tested unless t in full ition and RRA designation.	aducted on ambient conditions. otherwise stated. cal Manager min, Kim Sep 1, 2021
<ul> <li>Temperature</li> <li>* Unless specif</li> <li><b>3.</b> Test Resu</li> <li>The results shown This Test Report This test report is</li> </ul>	<pre>vironment : e: (25 ± 5) °C, Humidity: I ied otherwise in the individuant its : Refer to the test resenant this test report refer only f cannot be reproduced, excep not related to KOLAS recogn  Tested by Woohyoung, Jeong</pre>	Less than 75 % R.H. al methods, the tests were con sults to the sample(s) tested unless t in full ition and RRA designation. (signature) Technic Changr	aducted on ambient conditions. otherwise stated. cal Manager min, Kim Sep 1, 2021 D., LTPROSE



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## 1. General Information's <u>1.1 Test Performed</u>

Laboratory	:	NCT Co., Ltd.
Address	:	211-71, Geumgok-ro, Hwaseong-si, Gyeonggi-do, 18511, Korea
Telephone	:	+82-31-323-6070
Facsimile	:	+82-31-323-6071
FCC Designation No.	:	KR0166
FCC Registration No.	:	409631
IC Site Registration No.	:	25897

## 2. Information's about Test Item

## 2.1 Applicant Information

Company name	:	SENA TECHNOLOGIES.Inc
Address	:	19, Heolleung-ro 569-gil, Gangnam-gu, Seoul, Korea
Telephone / Facsimile	:	+82-2-571-8283 / +82-2-573-7710

## 2.2 Equipment Under Test (EUT) description

Test item particulars	:	A20
Model and/or type reference	:	SP100
Additional model name	:	SP100-A
Serial number	:	Prototype
Antenna type and gain	:	Chip Antenna(M/N: M10) with Max gain: 0.3 $^{ m dBi}$
Date (s) of performance of tests:	:	2021-07-28 ~ 2021-08-05
Date of receipt of test item	:	2021-06-28
EUT condition	:	Pre-production, not damaged
Number of channel	:	79
EUT Power Source	:	DC 3.7 V
Type of Modulation	:	BDR Mode(GFSK), EDR Mode(Pi/4 DQPSK, 8DPSK)
Firmware version	:	1.0
Hardware version	:	1.0
Test software name(version)	:	Qualcomm BlueSuite_BlueTest3(3.3.5)



## 2.3 Tested Frequency

Test Mode	Test frequency (Mz)			
Test Mode	Low frequency	Middle frequency	High frequency	
GFSK	2 402	2 441	2 480	
Pi/4 DQPSK	2 402	2 441	2 480	
8DPSK	2 402	2 441	2 480	

## 2.4 Used Test Software Setting Value

Test Mede	Setting Item			
Test Mode	Atn	Мад	Ехр	
GFSK	10	4	2	
Pi/4 DQPSK	4	5	2	
8DPSK	4	5	2	

## 2.5 Worst-Case

BDR	GFSK(DH5)	
EDR	8DPSK(3-DH5)	

Note: The power measurement has been conducted to determine the worst-case mode from all possible combinations between

available modulations, data rates.



## 3. Test Report

3.1 T	est S	Sum	mary
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Applied	FCC Rule	IC Rule	Test Items	Test Condition	Result
$\boxtimes$	15.203	-	Antenna Requirement		С
$\boxtimes$	15.247(a)	-	20 dB Bandwidth		С
$\boxtimes$	-	RSS GEN (6.7)	Occupied Bandwidth (99%)		С
$\boxtimes$	15.247(a)	RSS-247 (5.1)	Number of Hopping Frequencies		С
$\boxtimes$	15.247(a)	RSS-247 (5.1)	Time of Occupancy (Dwell Time)	Conducted -	С
$\boxtimes$	15.247(a)	RSS-247 (5.1)	Carrier Frequencies Separation		С
$\boxtimes$	15.247(b)	RSS-247 (5.4)	Peak Output Power		С
$\boxtimes$	15.247(d)	RSS-247 (5.5)	Conducted Spurious Emission		С
	15.247(d)	RSS-247 (5.5)			<u> </u>
$\boxtimes$	15.205 &	RSS-GEN	Radiated Spurious Emission	Radiated	С
	15.209	(8.9 & 8.10)			
$\boxtimes$	15.207	RSS-GEN (8.8)	Conducted Emissions	AC Line	С
			C		

Note 1: C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable

The sample was tested according to the following specification: ANSI C63.10:2013.

Compliance was determined by specification limits of the applicable standard according to customer requirements.



## 3.2 Test Report Version

Test Report No.	Date	Description
NW2108-F003	2021-08-26	Initial issue
NW2108-F003-1	2021-09-01	Add additional model name



## 3.3 Transmitter Requirements

## 3.3.1 Antenna Requirement

According to §15.203 An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

According to \$15.247(b)(4) e conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

#### 3.3.1.1 Result

#### Complies

(The transmitter has a Chip Antenna. The directional peak gain of the antenna is 0.3 dBi.)



## 3.3.2 20 dB Bandwidth & Occupied Bandwidth (99%)

#### 3.3.2.1 Test Setup

Refer to the APPENDIX I.

#### 3.3.2.2 Limit

Limit : Not Applicable

#### 3.3.2.3 Test Procedure

- 1. The 20 dB bandwidth & Occupied bandwidth were measured with a spectrum analyzer connected to RF antenna Connector (conducted measurement) while EUT was operating in transmit mode. The analyzer center frequency was set to the EUT carrier frequency, using the analyzer.
- The bandwidth of the fundamental frequency was measured with the spectrum analyzer using below setting: RBW = 1% to 5% of the 20 dB Bandwidth & Occupied Bandwidth

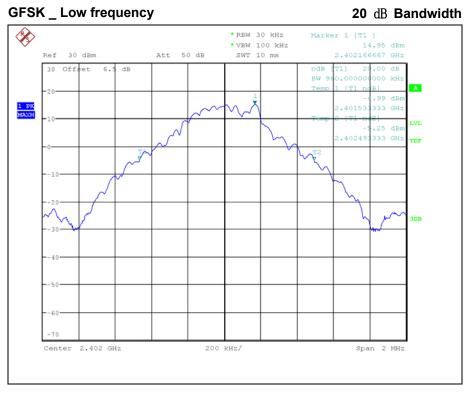
 $\label{eq:stability} VBW \geq 3 \times RBW$ Span = between two times and five times the 20 dB Bandwidth & Occupied Bandwidth Sweep = Auto Detector function = Peak Trace = Max Hold

Test Mode	Test Frequency	20 <sup>dB</sup> Bandwidth ( <sup>M≵</sup> )	Occupied Bandwidth ( <sup>Mb</sup> )	
	Low	0.960	0.870	
GFSK	Middle	0.960	0.863	
	High	0.960	0.863	
	Low	1.310	1.180	
8DPSK	Middle	1.313	1.183	
	High	1.303	1.190	

#### 3.3.2.4 Test Result

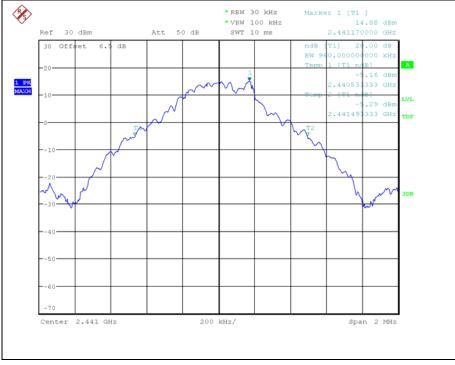


#### 3.3.2.5 Test Plot





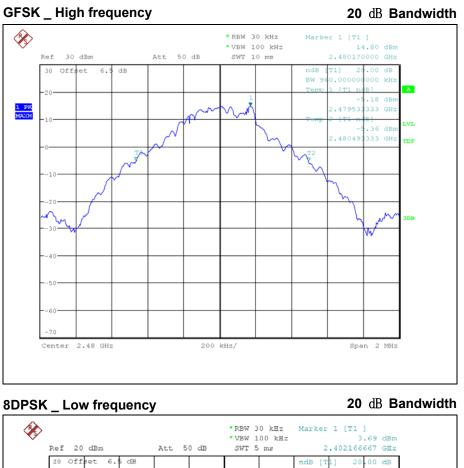
20 dB Bandwidth

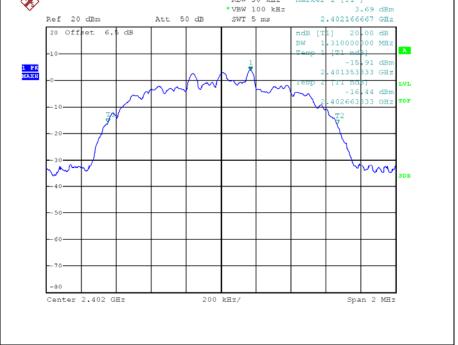


#### Test Repot No.: NW2108-F003-1

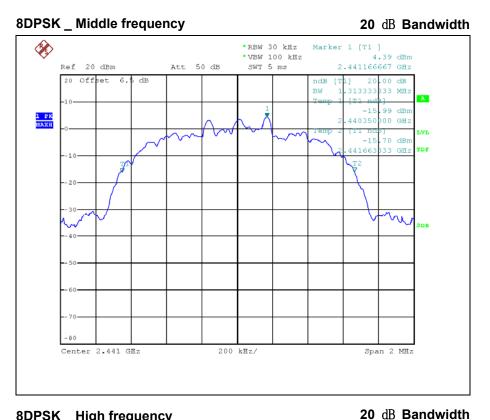
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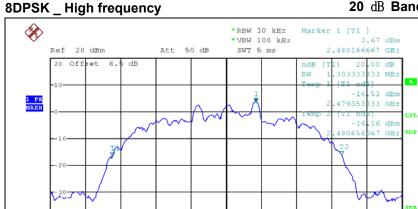












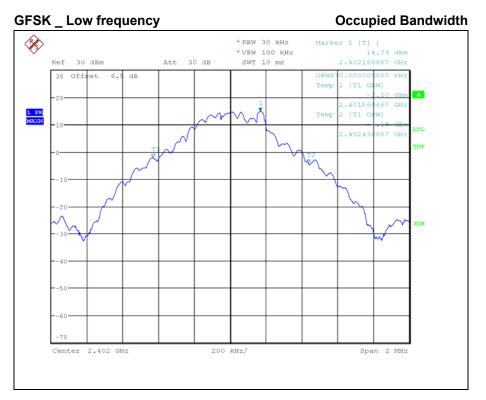
80

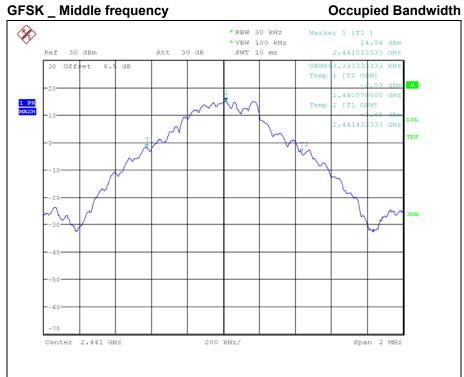
Center 2.48 GHz

200 kHz/

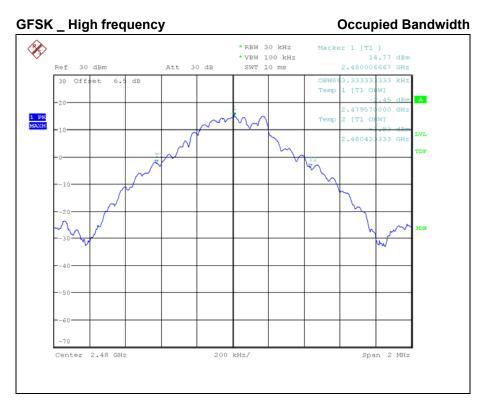
Span 2 MHz









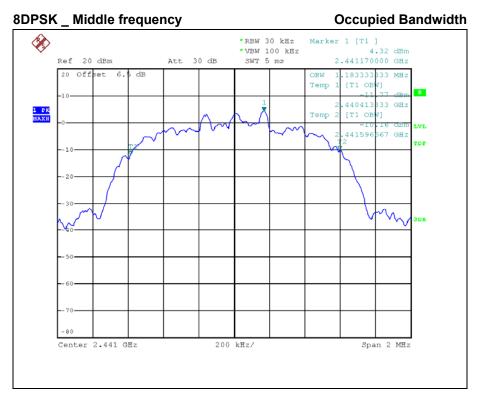


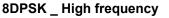


**Occupied Bandwidth** 

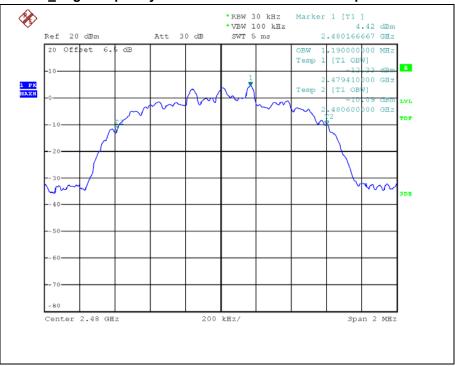














## 3.3.3 Number of Hopping Frequencies

#### 3.3.3.1 Test Setup

Refer to the APPENDIX I.

#### 3.3.3.2 Limit

Limit : >= 15 hops

#### 3.3.3.3 Test Procedure

The number of hopping frequencies was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function enabled.

To get higher resolution, two frequency ranges for FH mode within the 2400 ~ 2483.5 Mb were examined.

The spectrum analyzer is set to:

Span = 50 Mtz

RBW = To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.

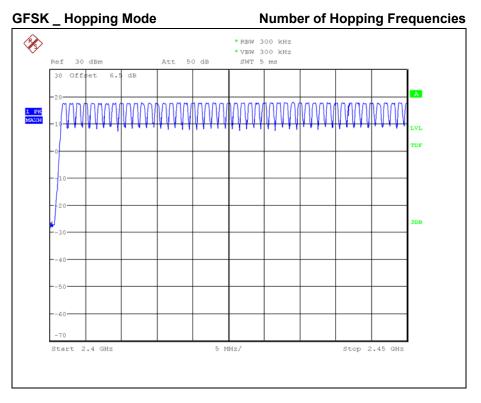
$VBW \geq RBW$	Sweep = Auto
Detector = Peak	Trace = Max hold

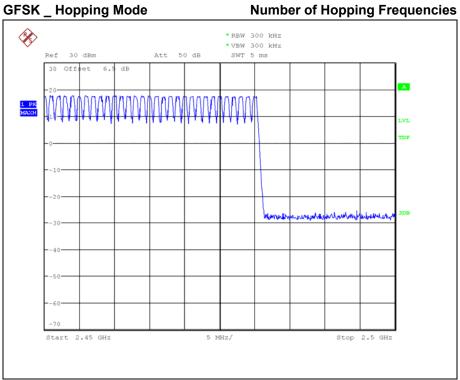
#### 3.3.3.4 Test Result

Test Mode	Number of Hopping Channels
GFSK	79
8DPSK	79



#### 3.3.3.5 Test Plot



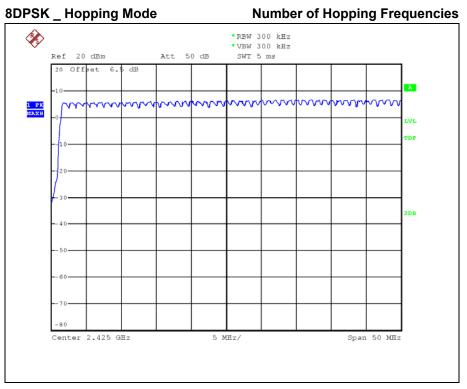


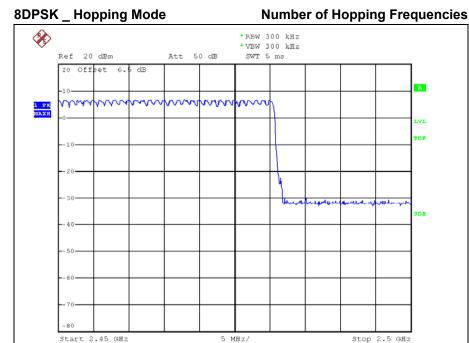
**Number of Hopping Frequencies** 

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## 3.3.4 Time of Occupancy (Dwell Time)

#### 3.3.4.1 Test Setup

Refer to the APPENDIX I.

#### 3.3.4.2 Limit

The maximum permissible time of occupancy is 400 ms within a period of 400 ms multiplied by the number of hopping channels employed.

#### 3.3.4.3 Test Procedure

The dwell time was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function enabled.

The spectrum analyzer is set to:

 Center frequency = 2441 M₂
 Span = Zero

 RBW = 1 M₂ (RBW shall be ≤ channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel)

 VBW ≥ RBW
 Detector = Peak

 Trace = Max hold

#### 3.3.4.4 Test Result

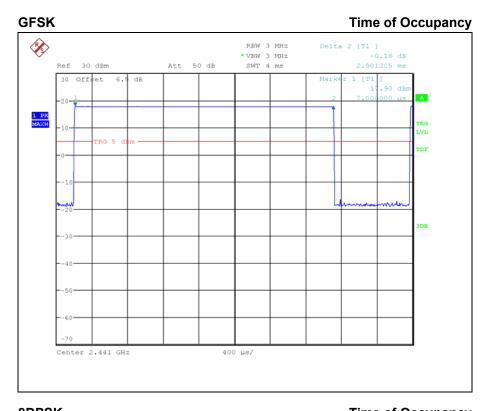
Test Mode	Number of Hopping Channels	Burst On Time (ms)	Result (sec)	Limit (sec)	
GFSK (non-AFH)	79	2.901	0.31	0.40	
GFSK (AFH)	20	2.901	0.15	0.40	
8DPSK (non-AFH)	79	2.916	0.31	0.40	
8DPSK (AFH)	20	2.916	0.16	0.40	

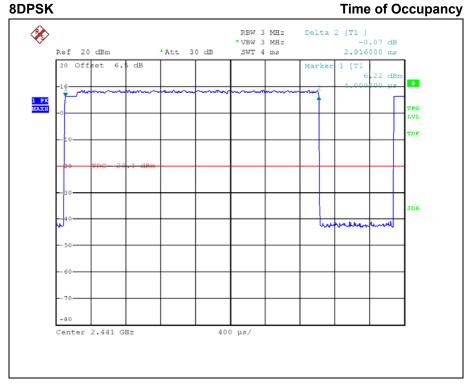
Note: Dwell Time = 0.4 x Hopping channel x Burst On Time x ((Hopping rate / Time slots) / Hopping channel) - Time slots for DH5 = 6 slots (TX = 5 slot / RX = 1 slot)

- Hopping Rate = 1600 for FH mode & 800 for AFH mode



#### 3.3.4.5 Test Plot





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## 3.3.5 Carrier Frequencies Separation

#### 3.3.5.1 Test Setup

Refer to the APPENDIX I.

#### 3.3.5.2 Limit

Limit :  $\geq$  25 kHz or  $\geq$  Two-Thirds of the 20 dB Bandwidth whichever is greater.

#### 3.3.5.3 Test Procedure

The carrier frequency separation was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function enabled.

After the trace being stable, the reading value between the peaks of the adjacent channels using the marker delta function was recorded as the measurement results.

The spectrum analyzer is set to:

Span = wide enough to capture the peaks of two adjacent channels

RBW = Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.

$VBW \geq RBW$	-	Sweep = Auto
Detector = Peak		Trace = Max hold

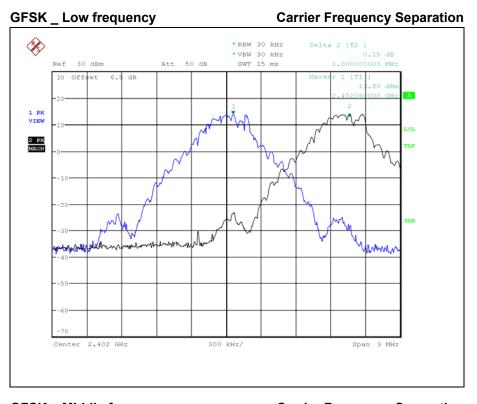
Test Mode	Test Frequency	Carrier Frequencies Separation ( <sup>(स्रि</sup> )	Min. Limit ( <sup>kłz</sup> )
	Low	1.000	0.640
GFSK	Middle	1.000	0.640
	High	1.005	0.640
	Low	1.005	0.873
8DPSK	Middle	1.000	0.875
	High	1.000	0.869

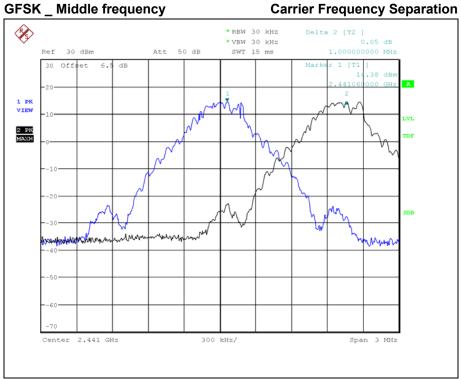
#### 3.3.5.4 Test Result

Note: Limit(klz) = Test Result of 20 dB BW \* 2/3



#### 3.3.5.5 Test Plot

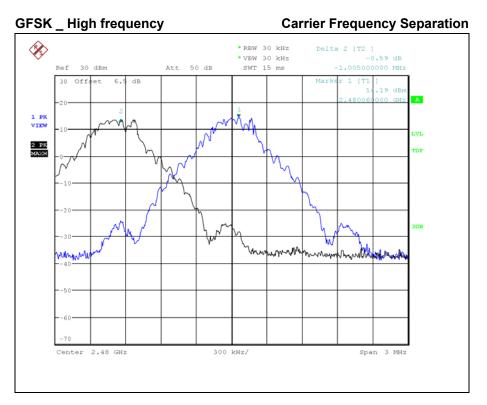


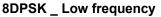


#### Test Repot No.: NW2108-F003-1

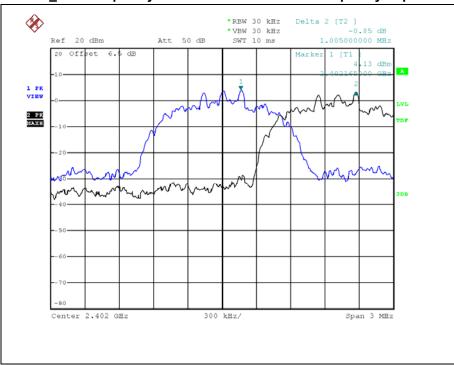
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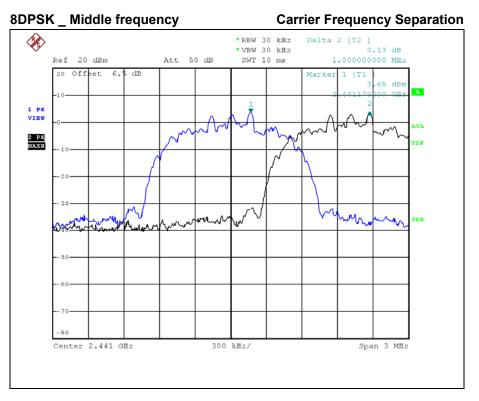




**Carrier Frequency Separation** 

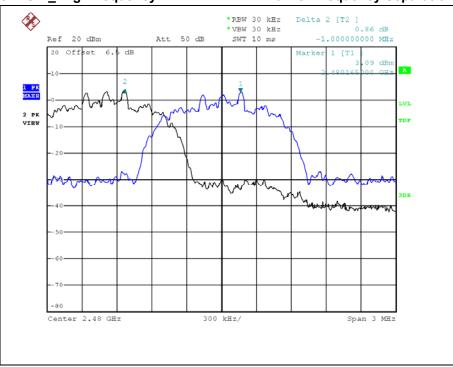






8DPSK \_ High frequency

**Carrier Frequency Separation** 





## 3.3.6 Peak Output Power

#### 3.3.6.1 Test Setup

Refer to the APPENDIX I.

#### 3.3.6.2 Limit

#### FCC Requirements

The maximum peak output power of the intentional radiator shall not exceed the following:

- 1. §15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
- 2. §15.247(b)(1), For frequency hopping systems operating in the 2400 2483.5 Mb employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725 5805 Mb band: 1 Watt. For all other frequency hopping systems in the 2400-2483.5 Mb band: 0.125 watts.

#### IC Requirements

1. RSS-247(5.4) (b), For FHSS operating in the band 2400 - 2483.5 MHz, the maximum peak conducted output power shall not exceed 1.0 W if the hopset uses 75 or more hopping channels, the maximum peak conducted output power shall not exceed 0.125 W if the hopset uses less than 75 hopping channels. The e.i.r.p shall not exceed 4 W, except as provided in section 5.4(e)

#### 3.3.6.3 Test Procedure

- 1. The RF output power was measured with a spectrum analyzer connected to the RF Antenna connector (conducted measurement) while EUT was operating in transmit mode at the appropriate center frequency, a spectrum analyzer was used to record the shape of the transmit signal.
- 2. The peak output power of the fundamental frequency was measured with the spectrum analyzer using;

Span = approximately 5 times of the 20 dB bandwidth, centered on a hopping channel

 $RBW \ge 20 \, dB$  Bandwidth  $VBW \ge RBW$ Sweep = Auto Detector function = Peak Trace = Max Hold



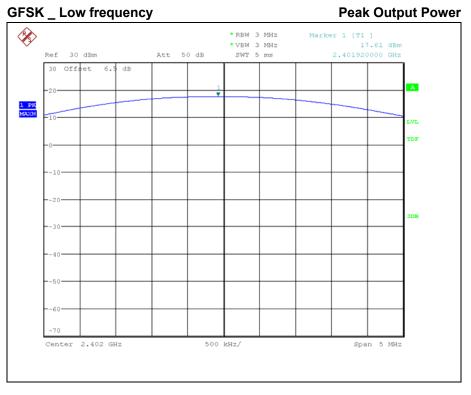
#### 3.3.6.4 Test Result

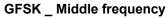
Test Mode	Toot Eroguonov	Peak Out	put Power	Frame Average Power		
Test Mode	Test Frequency	dBm	mW	dB <b>m</b>	mW	
	Low	17.61	57.68	16.68	46.56	
GFSK	Middle	17.84	60.81	17.32	53.95	
	High	17.94	62.23	16.71	46.88	
	Low	6.51	4.48	4.53	2.84	
Pi/4 DQPSK	Middle	8.28	6.73	5.47	3.52	
	High	9.30	8.51	5.32	3.40	
	Low	8.12	6.49	5.64	3.66	
8DPSK	Middle	8.84	7.66	5.40	3.47	
	High	9.42	8.75	5.76	3.77	

Note1: Frame Average Power was tested using an average power meter for reference only.

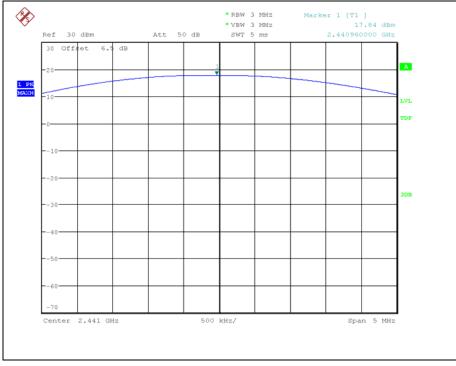


#### 3.3.6.5 Test Plot





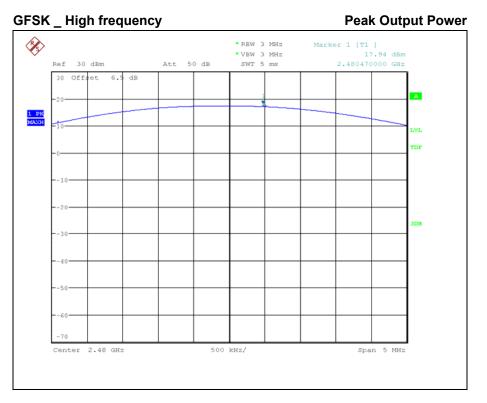
**Peak Output Power** 



#### Test Repot No.: NW2108-F003-1

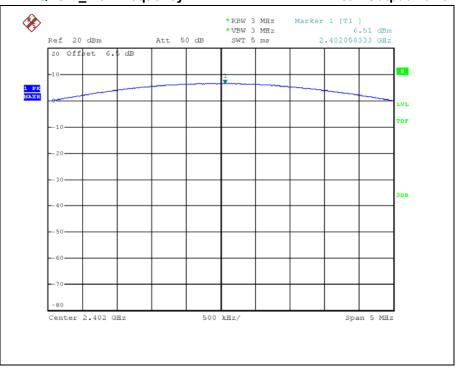
211-71, Geumgok-ro, Hwaseong-si, Gyeonggi-do, Korea 18511 www.nct.re.kr TEL: +82-31-323-6070 FAX: +82-31-323-6071



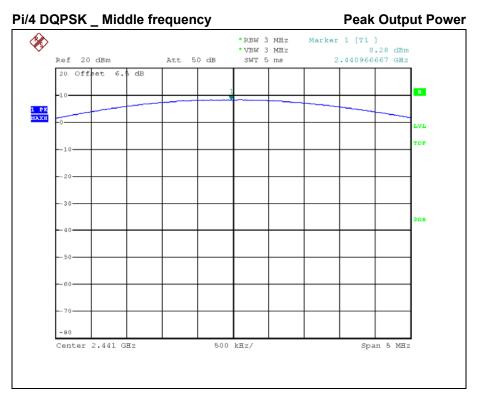


#### Pi/4 DQPSK \_ Low frequency



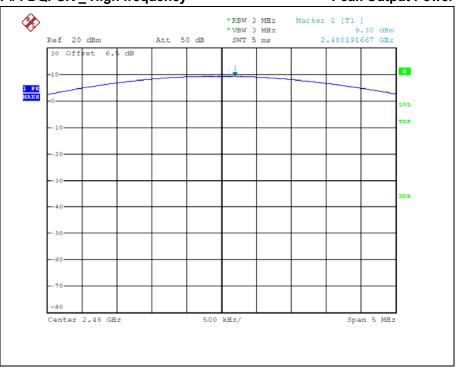




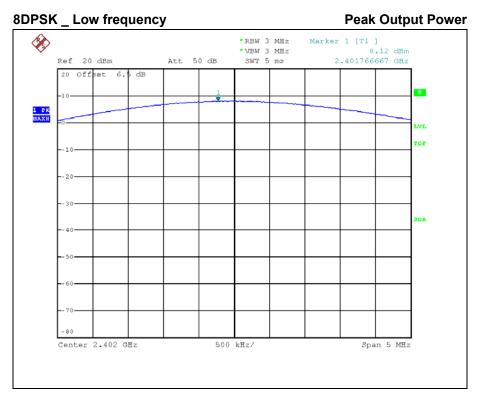






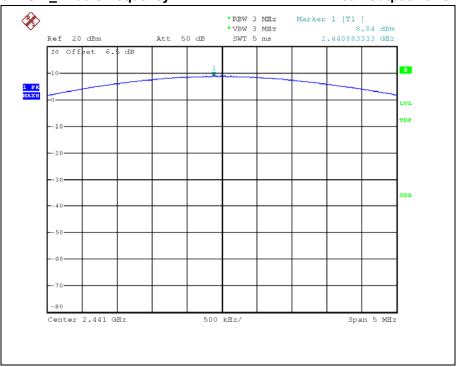




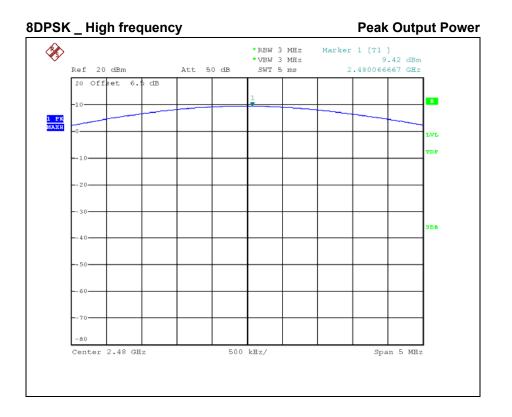


#### 8DPSK \_ Middle frequency











## 3.3.7 TX Radiated Spurious Emission and Conducted Spurious Emission

#### 3.3.7.1 Test Setup

Refer to the APPENDIX I.

#### 3.3.7.2 Limit

According to \$15.247(d), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph(b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in section \$15.209(a) is not required. In addition, radiated emission which in the restricted band, as define in section \$15.205(a), must also comply the radiated emission limits specified in section \$15.205(c))

According to § 15.209(a), except as provided elsewhere in this Subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table

Frequency (MHz)	Limit (uV/m)	Measurement Distance (meter)
0.009 ~ 0.490	2400/F (kHz)	300
0.490 ~ 1705	24000/F (kHz)	30
1705 ~ 30.0	30	30
30 ~ 88	100 **	3
88 ~ 216	150 **	3
216 ~ 960	200 **	3
Above 960	500	3

\*\* Except as provided in 15.209(g), fundamental emissions from intentional radiators operating under this Section shall not be located in the frequency bands 54 - 72 Mb, 76 - 88 Mb, 174 - 216 Mb or 470 - 806 Mb. However, operation within these frequency bands is permitted under other sections of this Part, e.g. 15.231 and 15.241.



According to § 15.205(a) and (b), only spurious emissions are permitted in any of the frequency bands listed below:

MHz	MHz	MHz	GHz
0.009 ~ 0.110	16.42 ~ 16.423	399.90 ~ 410	4.5 ~ 5.15
0.495 ~ 0.505	16.69475 ~ 16.69525	608 ~ 614	5.35 ~ 5.46
2.1735 ~ 2.1905	16.80425 ~ 16.80475	960 ~ 1240	7.25 ~ 7.75
4.125 ~ 4.128	25.5 ~ 25.67	1300 ~ 1427	8.025 ~ 8.5
4.17725 ~ 4.17775	37.5 ~ 38.	1435 ~ 1626.5	9.0 ~ 9.2
4.20725 ~ 4.20775	25 73 ~ 74.6	1645.5 ~ 1646.5	9.3 ~ 9.5
4.17725 ~ 4.17775	74.8 ~ 75.2	1660 ~ 1710	10.6 ~ 12.7
6.215 ~ 6.218	108 ~ 121.94	1718.8 ~ 1722.2	13.25 ~ 13.4
6.26775 ~ 6.26825	149.9 ~ 150.05	2200 ~ 2300	14.47 ~ 14.5
6.31175 ~ 6.31225	156.52475 ~ 156.52525	2310 ~ 2390	15.35 ~ 16.2
8.291 ~ 8.294	156.7 ~ 156.9	2483.5 ~ 2500	17.7 ~ 21.4
8.362 ~ 8.366	162.0125 ~ 167.17	2690 ~ 2900	22.01 ~ 23.12
8.37625 ~ 8.38675	3345.8 ~ 3358	3260 ~ 3267	23.6 ~ 24.0
8.41425 ~ 8.41475	3600 ~ 4400	3332 ~ 3339	31.2 ~ 31.8
12.51975 ~ 12.52025	3345.8 ~ 3358	240 ~ 285	36.43 ~ 36.5
12.57675 ~ 12.57725	3600 ~ 4400	322 ~ 335.4	Above 38.6
13.36 ~ 13.41			

The field strength of emissions appearing within these frequency bands shall not exceed the limits shown in §15.209. At frequencies equal to or less than 1000 Mb, compliance with the limits in §15.209 shall be demonstrated using measurement instrumentation employing a CISPR quasi-peak detector. Above 1000 Mb, compliance with the emission limits in §15.209 shall be demonstrated based on the average value of the measured emissions. The provisions in §15.35 apply to these measurements.



#### 3.3.7.3 Test Procedure for Radiated Spurious Emission

- 1. The EUT is placed on a non-conductive table. For emission measurements at or below 1 GHz, the table height is 80 cm. For emission measurements above 1 GHz, the table height is 1.5 m. The table was rotated 360 degrees to determine the position of the highest radiation.
- 2. During performing radiated emission below 1 GHz, the EUT was set 3 meters away from the interference receiving antenna, which was mounted on the top of a variable-height antenna tower. During performing radiated emission above 1 GHz, the EUT was set 1 or 3 meter away from the interference-receiving antenna.
- 3. For measurements above 1 GHz absorbers are placed on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1 GHz, the absorbers are removed.
- 4. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 5. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the table was turned from 0 degrees to 360 degrees to find the maximum reading. (The EUT was pre-tested with three axes (X, Y, Z) and the final test was performed at the worst case.)
- 6. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- 7. If the emission level of the EUT in peak mode was 10 dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10 dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

#### **Measurement Instrument Setting**

- 2. Frequency Range: Above 1 GHz

Peak Measurement RBW = 1 Mb, VBW = 3 Mb, Detector = Peak, Sweep time = Auto, Trace mode = Max Hold until the trace stabilizes

Average Measurement RBW =  $1M_{Z}$ , VBW  $\geq 1/T$ , Detector = Peak, Sweep Time = Auto, Trace Mode = Max Hold until the trace stabilizes



#### 3.3.7.4 Test Procedure for Conducted Spurious Emission

- 1. The transmitter output was connected to the spectrum analyzer.
- 2. The reference level of the fundamental frequency was measured with the spectrum analyzer using RBW = 100 kHz, VBW = 300 kHz.
- 3. The conducted spurious emission was tested each ranges were set as below. Frequency range: 30 Mb ~ 26.5 Gb
   RBW = 100 kb, VBW = 300 kb, Sweep Time = Auto, Detector = Peak, Trace = Max Hold

LIMIT LINE = 20 dB below of the reference level of above measurement procedure Step 2. (RBW = 100 kHz, VBW = 300 kHz)



#### 3.3.7.5 Test Result

#### 9 ktz ~ 25 Gtz Data (Modulation: GFSK)

#### • Low frequency

Reading		ding		Fastan	DOOF	Limits		Result		Margin		
Frequency	(dB u'	V/m)	Pol.	Factor (dB)	DCCF (dB)	(dB u'	(dBuV∕m)		V/m) (dB uV/m)		(d	B)
(Mtz)	AV /	/ Peak		(ab)	(ab)	AV / Peak		AV / Peak AV / Peak AV /		AV / Peak		Peak
2 389.68	N/A	42.04	н	17.65	-24.73	54.0	74.0	35.0	59.7	19.0	14.3	
4 803.76	N/A	50.69	н	-3.99	-24.73	54.0	74.0	22.0	46.7	32.0	27.3	
7 206.58	N/A	54.44	н	4.47	-24.73	54.0	74.0	34.2	58.9	19.8	15.1	
9 608.50	N/A	53.95	Н	5.20	-24.73	54.0	74.0	34.4	59.2	19.6	14.9	

#### Middle frequency

Reading	ding		Fastan	DOOF	Limits		Result		Margin			
Frequency	(dB u)	V/m)	Pol.	Factor	DCCF	(dBuV∕m)		ıV∕m) (dB uV∕m)		(d	B)	
(MHz)	AV /	/ Peak		(dB)	(dB)	AV / Peak		AV / Peak AV / Peak AV / P		AV / Peak		Peak
4 881.68	N/A	49.03	н	-3.95	-24.73	54.0	74.0	20.4	45.1	33.6	28.9	
7 323.58	N/A	53.94	н	4.53	-24.73	54.0	74.0	33.7	58.5	20.3	15.5	
9 763.64	N/A	49.42	н	5.66	-24.73	54.0	74.0	30.4	55.1	23.6	18.9	

#### • High frequency

		ding		Fastan			Limits		Result		Margin	
Frequency	(dB u)	V/m)	Pol.	Factor	DCCF	(dBuV∕m)		ˈdB uV/m) (dB uV/m)		(d	B)	
(MHz)	AV /	/ Peak		(dB)	(dB)	AV / Peak				AV / Peak		Peak
2 483.53	N/A	47.39	н	17.5	-24.73	54.0	74.0	40.2	64.9	13.8	9.1	
4 960.00	N/A	49.78	н	-3.94	-24.73	54.0	74.0	21.1	45.8	32.9	28.2	
7 440.56	N/A	54.01	н	4.55	-24.73	54.0	74.0	33.8	58.6	20.2	15.4	
9 920.48	N/A	51.69	н	5.81	-24.73	54.0	74.0	32.8	57.5	21.2	16.5	

Note 1: The radiated emissions were inverstigated 9  $kl_2$  to 25  $Gl_2$ . And no other spurious and harmonic emissions were found above listed frequencies.

Note 2: DCCF(Duty Cycle Correction Factor)

- Time to cycle through all channels =  $\Delta t$  = T [ms] X 20 minimum hopping channels, where T = pulse width = 2.901 ms

- 100 ms /  $\Delta$ t [ms] = H -> Round up to next highest integer, to account for worst case, H' = 100 / (2.901 X 20) = 1.72 = 2

- The Worst Case Dwell Time = T [ms] x H' = 2.901 ms X 2 = 5.80 ms

- DCCF = 20 x log(The Worst Case Dwell Time / 100 ms)  $\rm dB$  = 20 x log( 5.80 / 100 ) = -24.73  $\rm dB$ 

Note 3: Sample Calculation.

Margin = Limit – Result / Peak Result = Peak Reading + TF / Average Result = Peak Reading + TF + DCCF TF = Ant factor + Cable Loss + Filter Loss – Amp Gain



#### 9 ktz ~ 25 Gtz Data (Modulation: 8DPSK)

#### Low frequency

Frequency	Reading		Pol.	Fastan	DCCF (dB)	Limits		Result		Margin	
	(dB uV∕m)					(dB uV∕m)		(dB uV∕m)		(dB)	
(Mtz)	AV / Peak			(dB)		AV / Peak		AV / Peak		AV / Peak	
2 344.46	N/A	34.89	н	17.65	-24.68	54.0	74.0	27.9	52.5	26.1	21.5
4 804.14	N/A	55.04	н	-3.99	-24.68	54.0	74.0	26.4	51.1	27.6	23.0
7 206.06	N/A	62.98	н	4.47	-24.68	54.0	74.0	42.8	67.5	11.2	6.6
9 608.58	N/A	55.56	Н	5.20	-24.68	54.0	74.0	36.1	60.8	17.9	13.2

#### Middle frequency

Frequency	Reading		Pol. (dB)	Feeten	DOOF	Limits		Result		Margin	
	(dB uV∕m)			DCCF	(dB uV∕m)		(dB uV∕m)		(dB)		
(Młz)	AV / Peak				(dB)	AV / Peak		AV / Peak		AV / Peak	
4 882.04	N/A	53.92	н	-3.95	-24.68	54.0	74.0	25.3	50.0	28.7	24.0
7 323.56	N/A	60.58	н	4.53	-24.68	54.0	74.0	40.4	65.1	13.6	8.9
9 763.88	N/A	55.32	н	5.66	-24.68	54.0	74.0	36.3	61.0	17.7	13.0

#### • High frequency

Frequency	Reading		Pol. (dB)		<b>D</b> .005	Limits		Result		Margin	
	(dB uV∕m)			DCCF	(dB uV∕m)		(dB uV∕m)		(dB)		
(MHz)	AV / Peak				(dB)	AV / Peak		AV / Peak		AV / Peak	
2 483.50	N/A	53.34	н	17.5	-24.68	54.0	74.0	46.2	70.8	7.8	3.2
4 960.10	N/A	56.34	н	-3.94	-24.68	54.0	74.0	27.7	52.4	26.3	21.6
7 439.96	N/A	57.46	н	4.55	-24.68	54.0	74.0	37.3	62.0	16.7	12.0
9 919.88	N/A	56.31	Н	5.81	-24.68	54.0	74.0	37.4	62.1	16.6	11.9

Note 1: The radiated emissions were inverstigated 9  $\,\rm kl\!k$  to 25  $\,\rm Gl\!k.$ 

Note 2: DCCF(Duty Cycle Correction Factor)

- Time to cycle through all channels =  $\Delta t = T$  [ms] X 20 minimum hopping channels, where T = pulse width = 2.916 ms

- 100 ms /  $\Delta t$  [ms] = H -> Round up to next highest integer, to account for worst case, H' = 100 / (2.916 X 20) = 1.71  $\approx$  2

- The Worst Case Dwell Time = T [ms] x H' = 2.916 ms X 2 = 5.83 ms

- DCCF = 20 x log(The Worst Case Dwell Time / 100 ms) dB = 20 x log( 5.83 / 100 ) = -24.68 dB

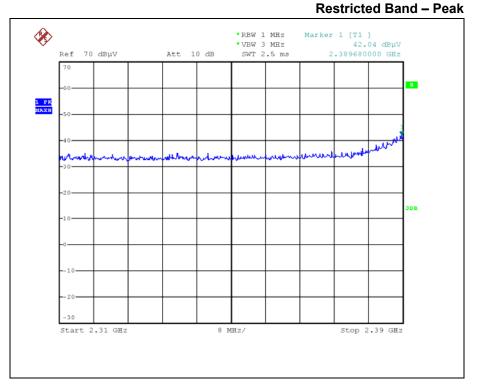
Note 3: Sample Calculation.

Margin = Limit – Result / Peak Result = Peak Reading + TF / Average Result = Peak Reading + TF + DCCF TF = Ant factor + Cable Loss + Filter Loss – Amp Gain

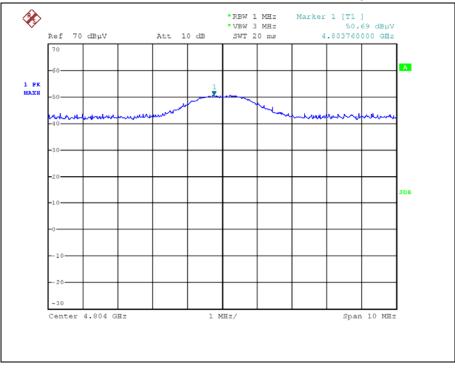


#### 3.3.7.6 Test Plot for Radiated Spurious Emission

• GFSK \_ Low frequency

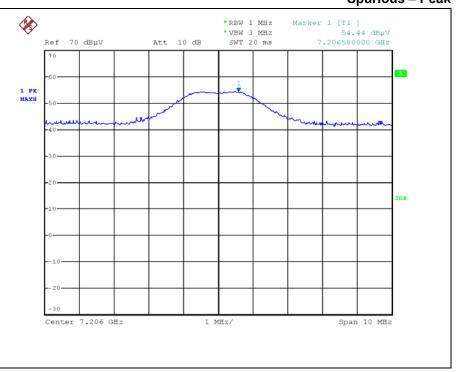


Spurious – Peak



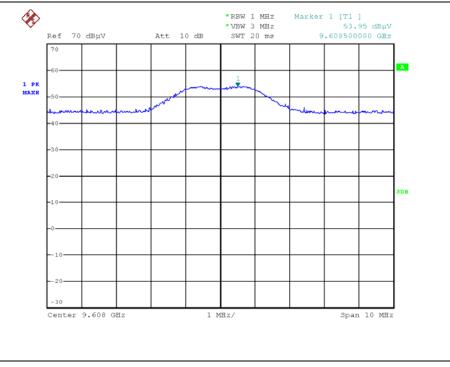
#### Test Repot No.: NW2108-F003-1





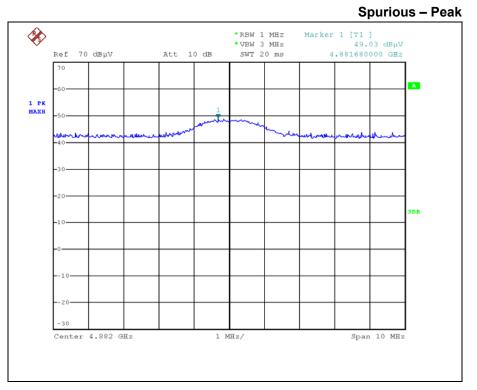




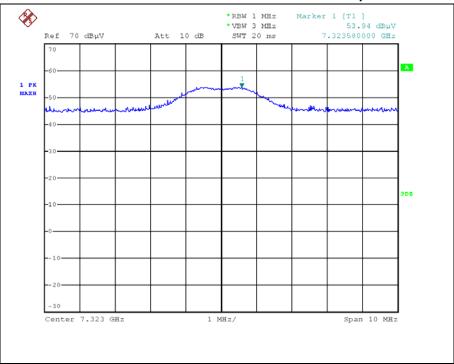




#### • GFSK \_ Middle frequency

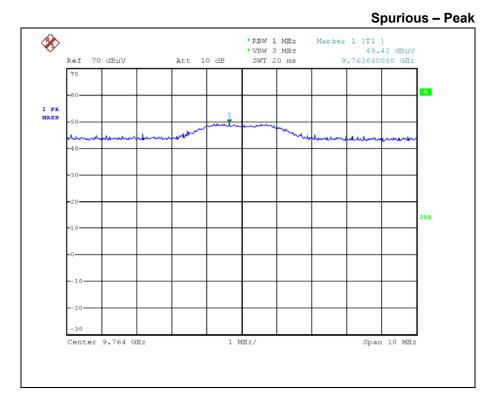


Spurious – Peak



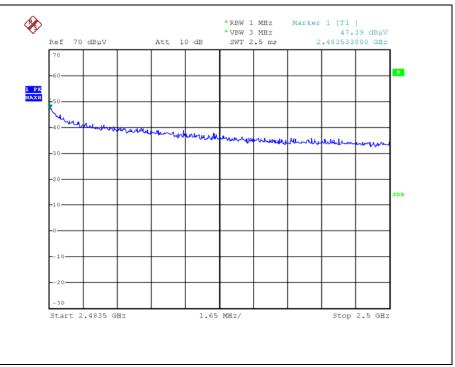
# Test Repot No.: NW2108-F003-1





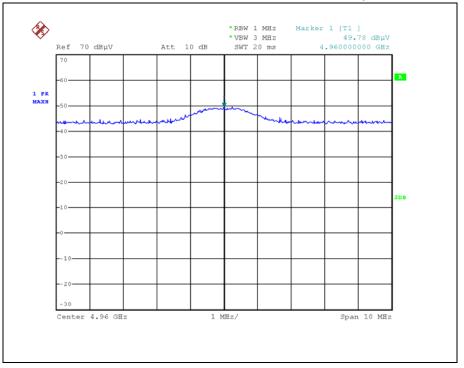


• GFSK \_ High frequency

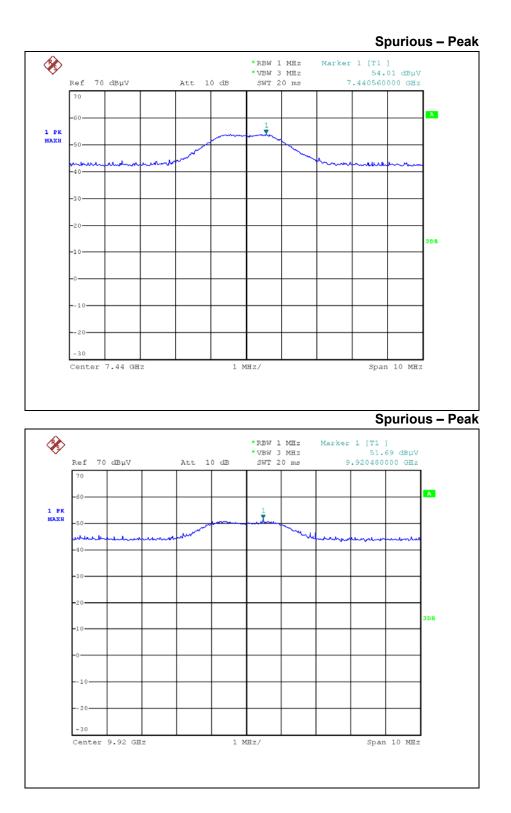


Restricted Band - Peak

Spurious – Peak



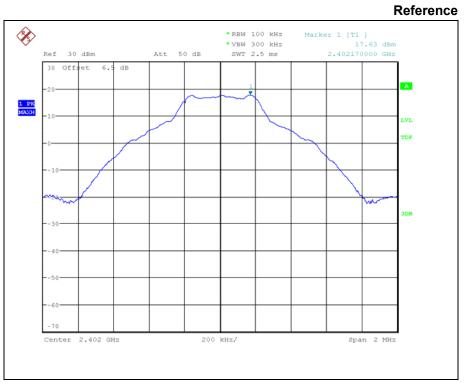




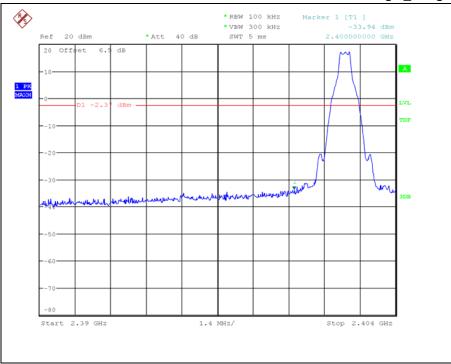


# 3.3.7.7 Test Plot for Conducted Spurious Emission

• GFSK \_ Low frequency

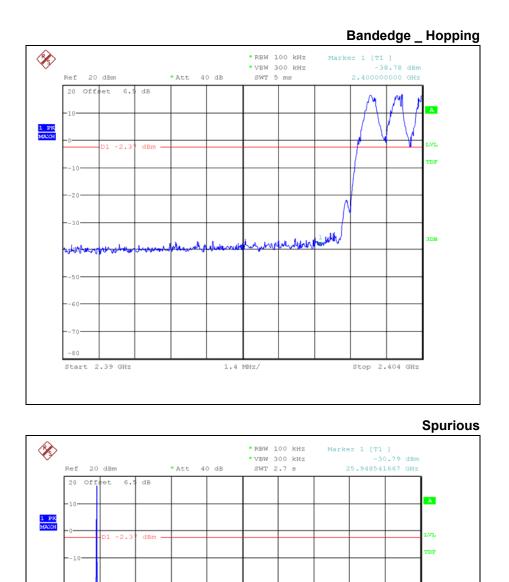


Bandedge \_ Single



#### Test Repot No.: NW2108-F003-1





2.647 GHz/

hundrennen

R. Much

Start 30 MHz

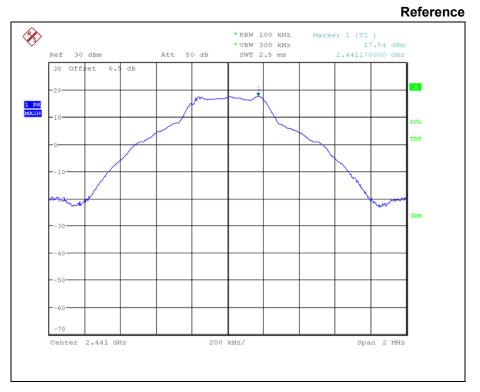
mound

Stop 26.5 GHz

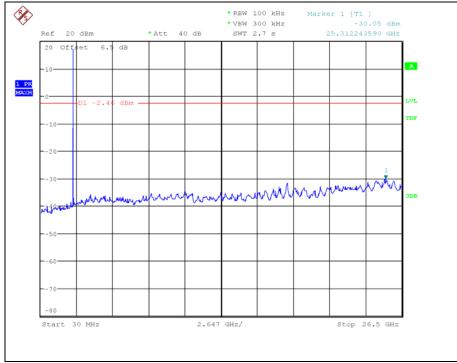
monthing



#### • GFSK \_ Middle frequency



#### **Spurious**



#### Test Repot No.: NW2108-F003-1



# • GFSK \_ High frequency



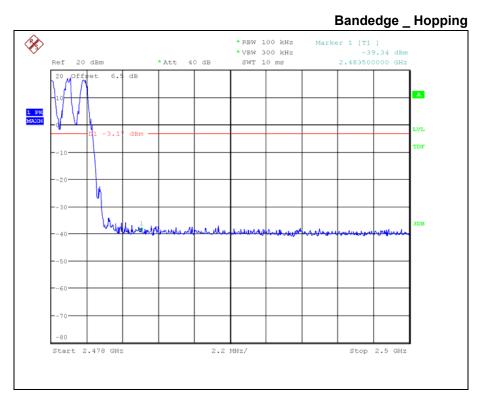
# Test Repot No.: NW2108-F003-1

2.2 MHz/

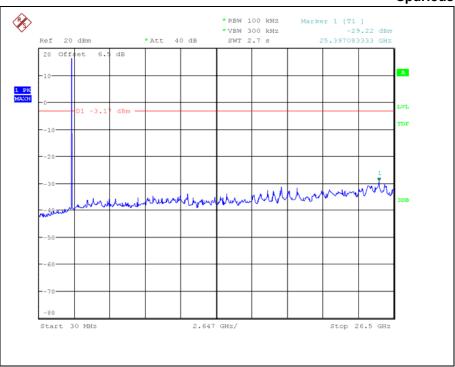
Stop 2.5 GHz

Start 2.478 GHz







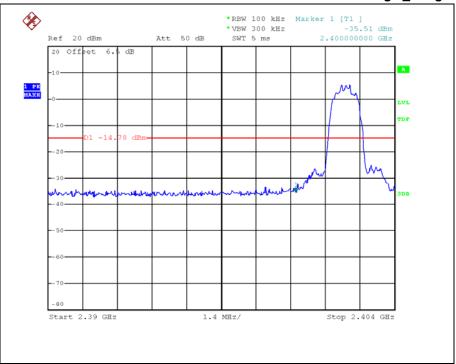




• 8DPSK \_ Low frequency

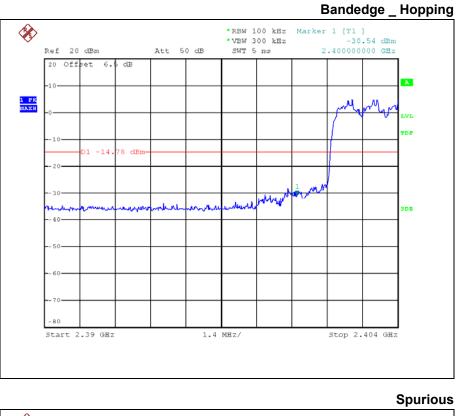
 Personal
 <th

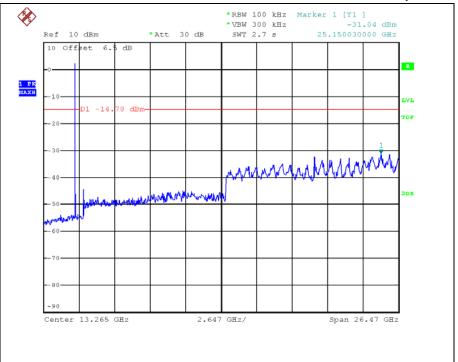
Bandedge \_ Single



# Test Repot No.: NW2108-F003-1





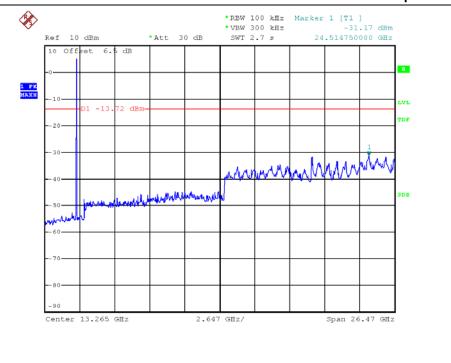




#### • 8DPSK \_ Middle frequency

Reference  $\otimes$ \*RBW 100 kHz Marker 1 [T1 ] \*VBW 300 kHz SWT 5 ms 6.28 dBm 2.441166667 GHz Ref 20 dBm Att 50 dB 20 Offset 6.5 dB A ź 1 PK MAXH LVL TDF 20 DB Center 2.441 GHz Span 2 MHz 200 kHz/

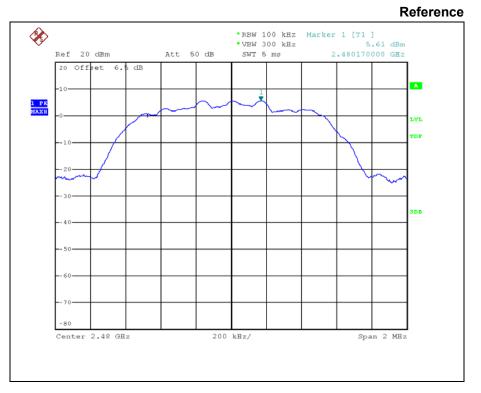
**Spurious** 



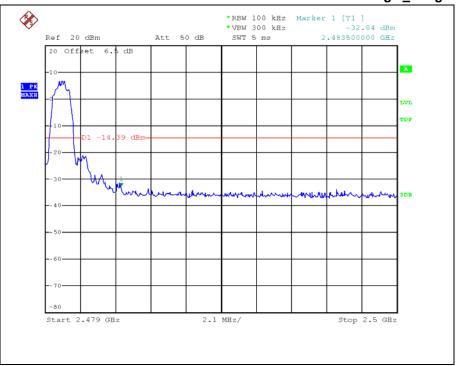
# Test Repot No.: NW2108-F003-1



## • 8DPSK \_ High frequency

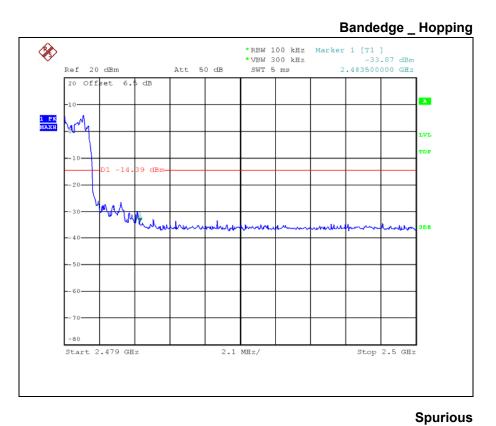


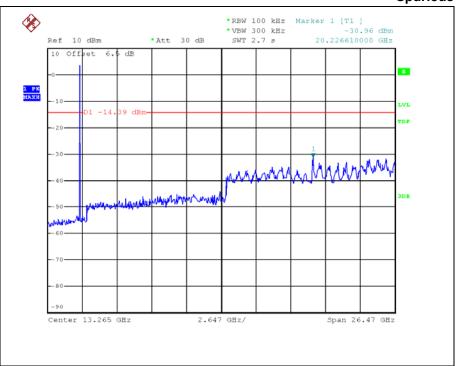
Bandedge \_ Single



# Test Repot No.: NW2108-F003-1









# 3.3.8 Conducted Emission

# 3.3.8.1 Test Setup

See test photographs for the actual connections between EUT and support equipment.

#### 3.3.8.2 Limit

According to §15.207(a) for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 k to 30 M, shall not exceed the limits in the following table, as measured using a 50 uH/50 ohm line impedance stabilization network (LISN).

Compliance with the provision of this paragraph shall on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower applies at the boundary between the frequency ranges.

Frequency Range (\\\z	Conducted Limit (dBuV)				
	Quasi-Peak	Average			
0.15 ~ 0.5	66 to 56 *	56 to 46 *			
0.5 ~ 5	56	46			
5 ~ 30	60	50			

\* Decreases with the logarithm of the frequency

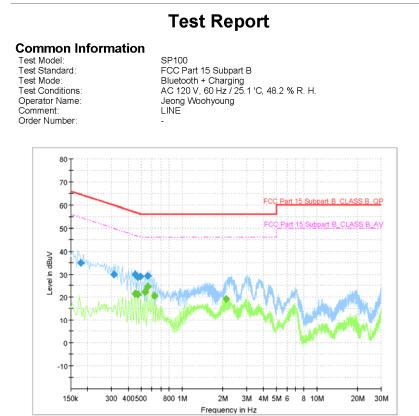
#### 3.3.8.3 Test Procedure

Conducted emissions from the EUT were measured according to the ANSI C63.10.

- 1. The test procedure is performed in a 6.5 m × 3.5 m × 3.5 m (L × W × H) shielded room. The EUT along with its peripherals were placed on a 1.0 m (W) × 1.5 m (L) and 0.8 m in height wooden table and the EUT was adjusted to maintain a 0.4 meter space from a vertical reference plane.
- 2. The EUT was connected to power mains through a line impedance stabilization network (LISN) which provides 50 ohm coupling impedance for measuring instrument and the chassis ground was bounded to the horizontal ground plane of shielded room.
- 3. All peripherals were connected to the second LISN and the chassis ground also bounded to the horizontal ground plane of shielded room.
- 4. The excess power cable between the EUT and the LISN was bundled. The power cables of peripherals were unbundled. All connecting cables of EUT and peripherals were moved to find the maximum emission.



- 3.3.8.4 Test Result
- AC Line Conducted Emission (Graph)



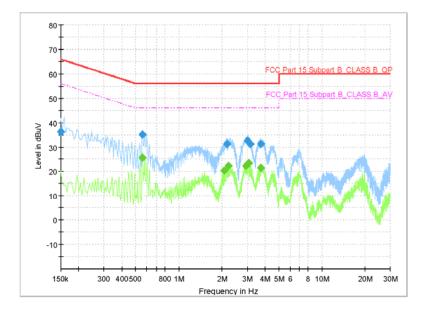
Final Result									
Frequency (MHz)	QuasiPeak (dBuV)	CAverage (dBuV)	Limit (dBuV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)	
0.178000	34.84		64.58	29.74	1000.0	9,000	L1	10.4	
0.312000	29.78		59.92	30.14	1000.0	9.000	L1	10.5	
0.448000		21.44	46.91	25.47	1000.0	9.000	L1	10.5	
0.448000	29.99		56.91	26.92	1000.0	9,000	L1	10.5	
0.469000	28.83		56.55	27.72	1000.0	9.000	L1	10.5	
0.472000		21.11	46.48	25.36	1000.0	9.000	L1	10.5	
0.492000	29.03		56.13	27.10	1000.0	9.000	L1	10.5	
0.536000		22.38	46.00	23.62	1000.0	9.000	L1	10.5	
0.556000		24.60	46.00	21.40	1000.0	9.000	L1	10.5	
0.556000	29.41		56.00	26.59	1000.0	9.000	L1	10.5	
0.624000		20.77	46.00	25.23	1000.0	9.000	L1	10.4	
2.132000		19.30	46.00	26.70	1000.0	9.000	L1	10.6	



# **Test Report**

#### **Common Information**

Test Model: Test Standard: Test Mode: Test Conditions: Operator Name: Comment: Order Number: SP100 FCC Part 15 Subpart B Bluetooth + Charging AC 120 V, 60 Hz / 25.1 'C, 48.2 % R. H. Jeong Woohyoung NEUTRAL



# Final Result

Frequency (MHz)	QuasiPeak (dBuV)	CAverage (dBuV)	Limit (dBuV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.150000	36.26		66.00	29.74	1000.0	9.000	N	10.4
0.556000		25.61	46.00	20.39	1000.0	9.000	N	10.4
0.560000	35.02		56.00	20.98	1000.0	9.000	N	10.4
2.068000		20.26	46.00	25.74	1000.0	9.000	N	10.6
2.176000	31.39		56.00	24.61	1000.0	9.000	N	10.6
2.222000		22.25	46.00	23.75	1000.0	9.000	N	10.6
2.944000		22.34	46.00	23.66	1000.0	9.000	N	10.6
3.030000	32.56		56.00	23.44	1000.0	9.000	Ν	10.6
3.096000		23.43	46.00	22.57	1000.0	9.000	Ν	10.6
3.164000	31.34		56.00	24.66	1000.0	9.000	Ν	10.6
3.720000	31.20		56.00	24.80	1000.0	9.000	Ν	10.7
3.742000		21.64	46.00	24.36	1000.0	9.000	Ν	10.7

# Test Repot No.: NW2108-F003-1



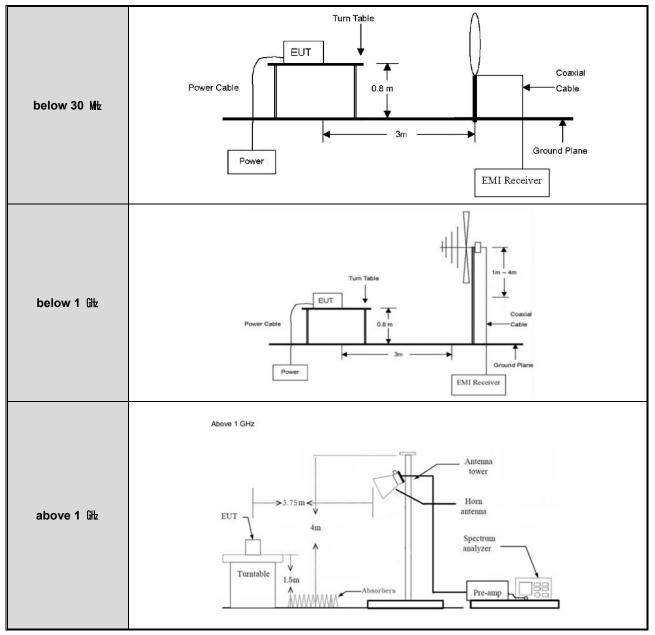
APPENDIX I

TEST SETUP

Test Repot No.: NW2108-F003-1



#### • Radiated Measurement



#### • Conducted Measurement

				_
Conducted	EUT	Attenuato	or Spectrum Analyzer	

# Test Repot No.: NW2108-F003-1



# APPENDIX II

# TEST EQUIPMENT USED FOR TESTS

Test Repot No.: NW2108-F003-1



	Description	Manufacturer	Serial No.	Model No.	Cal. Date	Next Cal. Date
1	SPECTRUM ANALYZER	R&S	100617	FSP40	2021-03-09	2022-03-09
2	SPECTRUM ANALYZER	R&S	100250	FSU26	2020-09-22	2021-09-22
3	Triple Output DC Power Supply	Agilent	MY40038816	E3631A	2021-03-09	2022-03-09
4	Power supply	GWInstek	EH120798	PST-3202	2021-03-09	2022-03-09
5	Humi./Baro/Temp. data recorder	Lutron	38420	MHB-382SD	2020-11-13	2021-11-13
6	8360B SERIES SWEPT SIGNAL GENERATOR	HP	3614A00312	83640B	2020-12-30	2021-12-30
7	LOOP-ANTENNA	Schwarzbeck	00124	FMZB1519 B	2021-06-01	2023-06-01
8	TRILOG Broadband Antenna	Schwarzbeck	01027	VULB 9168	2021-06-08	2023-06-08
9	Double Ridged Broadband Horn Antenna	Schwarzbeck	02087	BBHA 9120D	2021-06-02	2022-06-02
10	Broadband Horn Antenna	Schwarzbeck	00938	BBHA 9170	2021-06-01	2022-06-01
11	Amplifier	TESTEK	160011-L	TK-PA18H	2021-05-24	2022-05-24
12	Amplifier	TESTEK	190008-L	TK-PA1840H	2021-05-28	2022-05-28
13	ATTENUATOR	INMET	279465	40AH2W	2021-07-27	2022-07-27
14	ATTENUATOR	Weinschel	none	WA41/12-30-12	2021-03-09	2022-03-09
15	High Pass Filter	Mini-Circuits	1741	VHF-3100+	2021-03-09	2022-03-09
16	High Pass Filter	Mini-Circuits	1732	VHF-8400+	2021-03-09	2022-03-09
17	LISN	Schwarzbeck	00984	NSLK 8127	2020-09-24	2021-09-24
18	EMI Test Receiver	R&S	102138	ESR	2021-05-27	2022-05-27